

## **MOSFET**

#### 600V CoolMOS™ SJ S7 Power Device

IPT60R022S7 enables the best price performance for low frequency switching applications. CoolMOS™ S7 boasts the lowest Rdson values for a HV SJ MOSFET, with distinctive increase of energy efficiency.

CoolMOS™ S7 is optimized for "static switching" and high current applications. It is an ideal fit for solid state relay and circuit breaker designs as well as for line rectification in SMPS and inverter topologies.

# HSOF Tab Tab Tab Tab

#### **Features**

- CoolMOS™ S7 technology enables 22mΩ R<sub>DS(on)</sub> in the smallest footprint
- Optimized price performance in low frequency switching applications
- · High pulse current capability
- Kelvin Source pin improves switching performance at high current
- TOLL package is MSL1 compliant, total Pb-free, has easy visual inspection leads

#### **Benefits**

- Minimized conduction losses (eliminate / reduce heat sink)
- Increased system performance
- More compact and easier design
- Lower BOM or/and TCO over prolonged life time

Compared to electromechanical devices:

- Faster switching times
- · More reliability and longer system life time
- Shock & Vibration resistance
- No contact arcing, bouncing or degradation over life time

# **Potential applications**

- · Solid state relays and circuit breakers
- Line rectification in high power/performance applications e.g. Computing, Telecom, UPS and Solar

#### **Product validation**

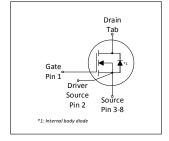
Fully qualified according to JEDEC for Industrial Applications

Please note: For paralleling 4pin MOSFET devices the placement of the gate resistor is generally recommended to be on the Driver Source instead of the Gate.



Table 1 Rey 1 chomianoc 1 arameters								
Parameter	Value	Unit						
R <sub>DS(on),max</sub>	22	mΩ						
$Q_{g,typ}$	150	nC						
V <sub>SD</sub>	0.82	V						
Pulsed I <sub>SD</sub> , I <sub>DS</sub>	375	Α						

Type / Ordering Code	Package	Marking	Related Links	
IPT60R022S7	PG-HSOF-8	60R022S7	see Appendix A	









# 600V CoolMOS™ SJ S7 Power Device IPT60R022S7



Rev. 2.1, 2021-10-25

# **Table of Contents**

cription	1
imum ratings	3
rmal characteristics	4
etrical characteristics	5
etrical characteristics diagrams	7
t Circuits	11
kage Outlines	12
endix A	13
ision History	14
demarks	14
elaimer	14





1 Maximum ratings at  $T_j = 25$ °C, unless otherwise specified

Table 2 **Maximum ratings** 

Devementar	Cross bod	Values					
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain current rating	ID	-	-	23	A	$T_C$ =140°C Current is limited by $T_{j max}$ = 150°C; Lower case temp does increase current capability	
Pulsed drain current <sup>1)</sup>	I <sub>D,pulse</sub>	-	-	375	Α	T <sub>C</sub> =25°C	
Avalanche energy, single pulse	<b>E</b> <sub>AS</sub>	-	-	289	mJ	I <sub>D</sub> =3.8A; V <sub>DD</sub> =50V; see table 10	
Avalanche current, single pulse	I <sub>AS</sub>	-	-	3.8	Α	-	
MOSFET dv/dt ruggedness <sup>2)</sup>	dv/dt	-	-	20	V/ns	V <sub>DS</sub> = 0V to 300V	
Gate source voltage (static)	V <sub>GS</sub>	-20	-	20	V	static	
Gate source voltage (dynamic)	V <sub>GS</sub>	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P <sub>tot</sub>	-	-	390	W	T <sub>C</sub> =25°C	
Storage temperature	T <sub>stg</sub>	-55	-	150	°C	-	
Operating junction temperature	T <sub>j</sub>	-55	-	150	°C	-	
Mounting torque	-	-	-	n.a.	Ncm	-	
Diode forward current rating	I <sub>S</sub>	-	-	23	A	$T_C$ =140°C Current is limited by $T_{j max}$ = 150°C; Lower case temp does increase current capability	
Diode pulse current <sup>1)</sup>	I <sub>S,pulse</sub>	-	-	375	Α	T <sub>C</sub> =25°C	
Reverse diode dv/dt <sup>3)</sup>	dv/dt	-	-	5	V/ns	V <sub>DS</sub> =0 to 300V, I <sub>SD</sub> <=23A, T <sub>j</sub> =25°C see table 8	
Maximum diode commutation speed di <sub>f</sub> /dt 1000 A/μ		A/μs	$V_{\rm DS}$ =0 to 300V, $I_{\rm SD}$ <=23A, $T_{\rm j}$ =25°C see table 8				
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	V <sub>rms</sub> , T <sub>C</sub> =25°C, t=1min	

 $<sup>^{1)}</sup>$  Pulse width  $t_p$  limited by  $T_{j,\text{max}}$   $^{2)}$  The dv/dt has to be limited by appropriate gate resistor  $^{3)}$  Identical low side and high side switch

IPT60R022S7



# 2 Thermal characteristics

**Table 3** Thermal characteristics

Paramatan.	Valu			Values		Nata / Tank Oamalikian
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R <sub>thJC</sub>	-	-	0.32	°C/W	-
Thermal resistance, junction - ambient	R <sub>thJA</sub>	-	-	62	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	$R_{ m thJA}$	-	35	45	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area for drain connection and cooling. PCB is vertical without air stream cooling.
Soldering temperature, wave- & reflow soldering allowed	T <sub>sold</sub>	-	-	260	°C	reflow MSL1

# 600V CoolMOS™ SJ S7 Power Device IPT60R022S7



## 3 Electrical characteristics

at  $T_i$ =25°C, unless otherwise specified

#### Table 4 Static characteristics

For applications with applied blocking voltage >70% of the specified blocking voltage, it is required that the customer evaluates the impact of cosmic radiation effect in early design phase and contacts the Infineon sales office for the necessary technical support by Infineon

Parameter	Ols al	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	600	-	-	V	$V_{GS}$ =0V, $I_{D}$ =1mA
Gate threshold voltage	$V_{(GS)th}$	3.5	4.0	4.5	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=1.44{\rm mA}$
Zero gate voltage drain current	I <sub>DSS</sub>	-	- 50	5	μΑ	V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>j</sub> =25°C V <sub>DS</sub> =600V, V <sub>GS</sub> =0V, T <sub>j</sub> =150°C
Gate-source leakage current	I <sub>GSS</sub>	-	-	100	nA	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.02 0.046	0.022	Ω	V <sub>GS</sub> =12V, I <sub>D</sub> =23A, T <sub>j</sub> =25°C V <sub>GS</sub> =12V, I <sub>D</sub> =23A, T <sub>j</sub> =150°C
Gate resistance	R <sub>G</sub>	-	0.80	-	Ω	f=1MHz, open drain

**Table 5** Dynamic characteristics

Parameter	0		Values			
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	Ciss	-	5639	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =300V, f=250kHz
Output capacitance	Coss	-	89	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =300V, f=250kHz
Effective output capacitance, energy related <sup>1)</sup>	C <sub>o(er)</sub>	-	303	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 300V
Effective output capacitance, time related <sup>2)</sup>	C <sub>o(tr)</sub>	-	2678	-	pF	$I_D$ =constant, $V_{GS}$ =0V, $V_{DS}$ =0 to 300V
Output charge	Qoss	-	803	-	nC	V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 300V
Turn-on delay time	t <sub>d(on)</sub>	-	30	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9
Rise time	t <sub>r</sub>	-	4	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9
Turn-off delay time	$t_{\sf d(off)}$	-	150	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9
Fall time	t <sub>f</sub>	-	9	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =23A, $R_{\rm G}$ =5.3 $\Omega$ ; see table 9

 Table 6
 Gate charge characteristics

Parameter	Cumbal	Values			11	Note / Test Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q <sub>gs</sub>	-	31	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate to drain charge	Q <sub>gd</sub>	-	49	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate charge total	Qg	-	150	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V
Gate plateau voltage	<b>V</b> <sub>plateau</sub>	-	5.4	-	V	$V_{\rm DD}$ =300V, $I_{\rm D}$ =23A, $V_{\rm GS}$ =0 to 12V

 $<sup>^{1)}</sup>$   $C_{\text{o(er)}}$  is a fixed capacitance that gives the same stored energy as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 300V  $^{2)}$   $C_{\text{o(tr)}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 300V

IPT60R022S7

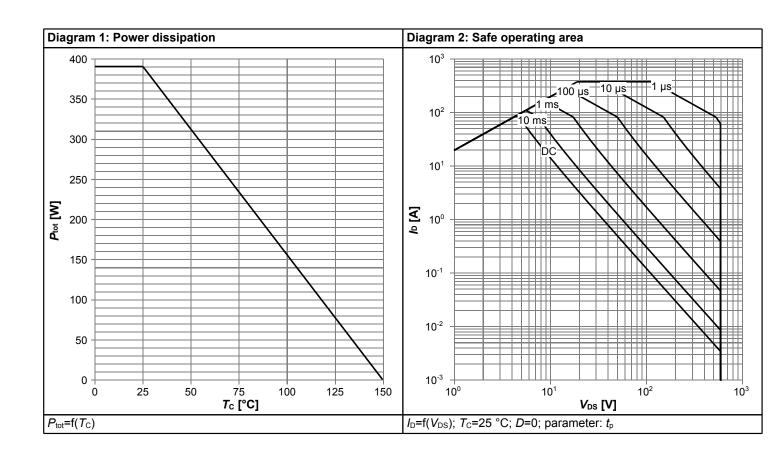


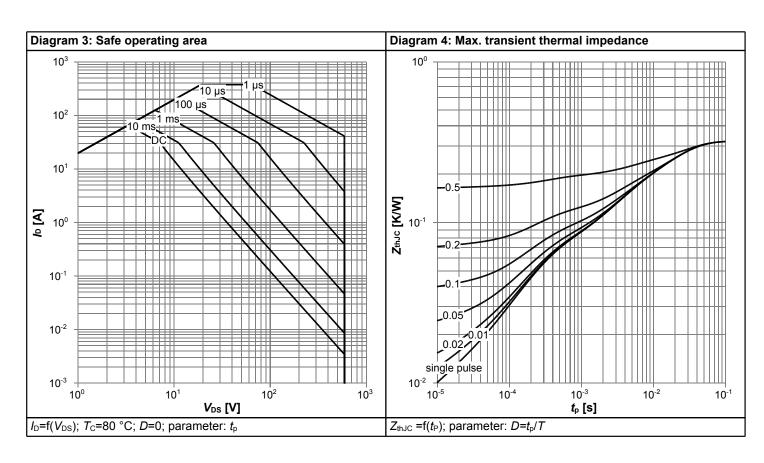
# Table 7 Reverse diode characteristics

Parameter	Cumbal	Values			11:4	Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	<b>V</b> <sub>SD</sub>	-	0.82	-	V	V <sub>GS</sub> =0V, I <sub>F</sub> =23A, T <sub>j</sub> =25°C
Reverse recovery time	t <sub>rr</sub>	-	460	-	ns	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Reverse recovery charge	Q <sub>rr</sub>	-	9	-	μC	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8
Peak reverse recovery current	I <sub>rrm</sub>	-	40	-	А	$V_R$ =300V, $I_F$ =23A, $di_F/dt$ =100A/ $\mu$ s; see table 8

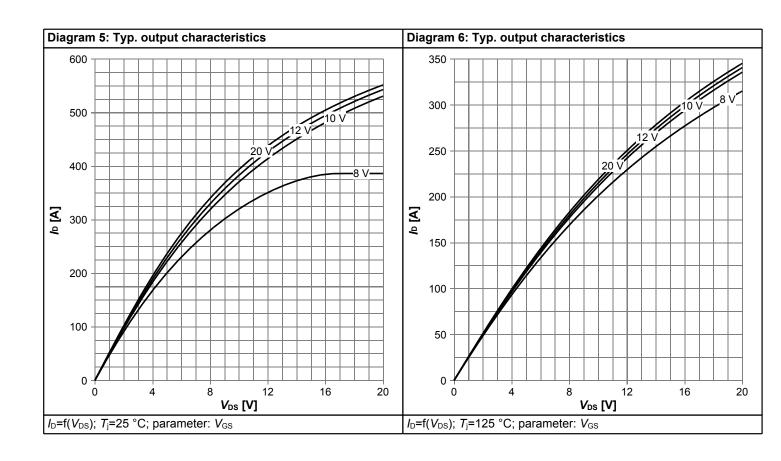


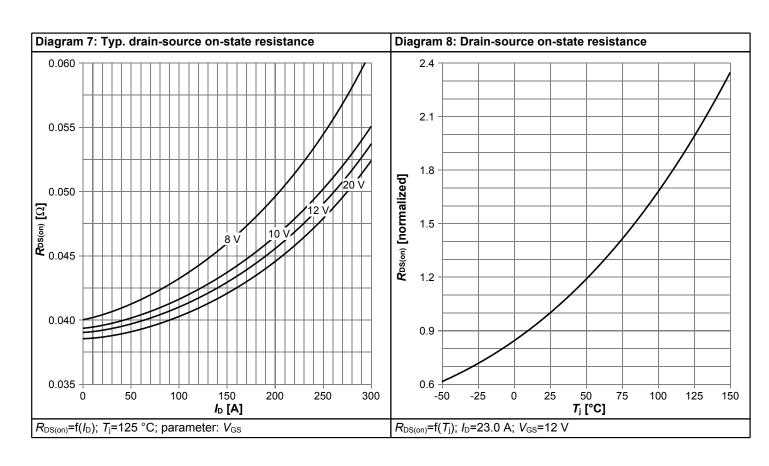
# 4 Electrical characteristics diagrams



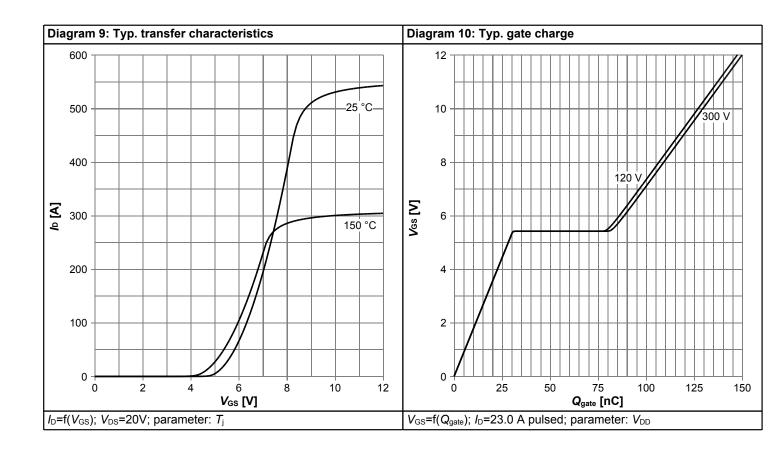


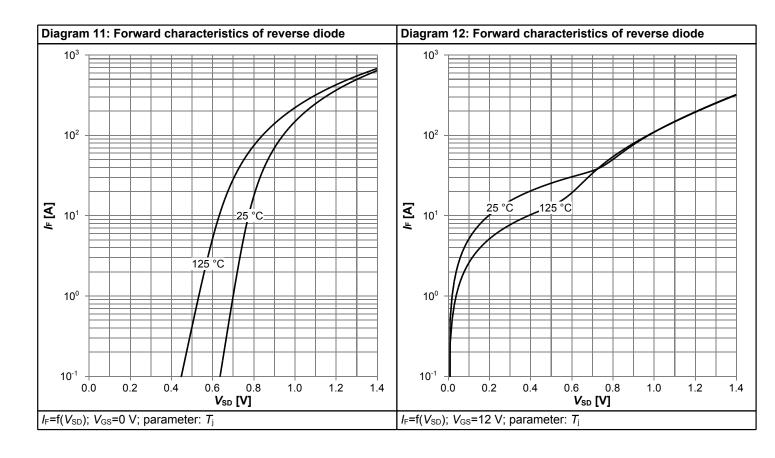




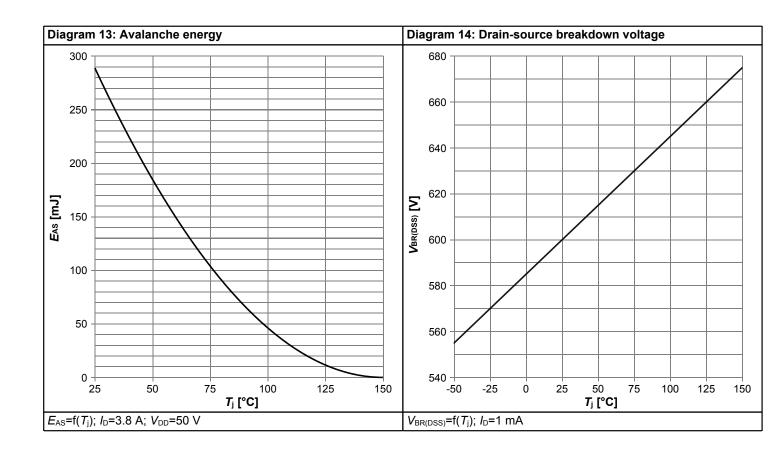


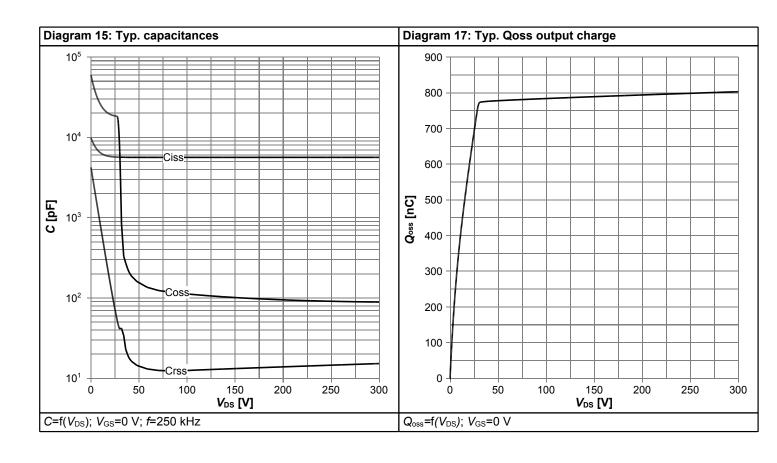














## 5 Test Circuits

**Table 8** Diode characteristics

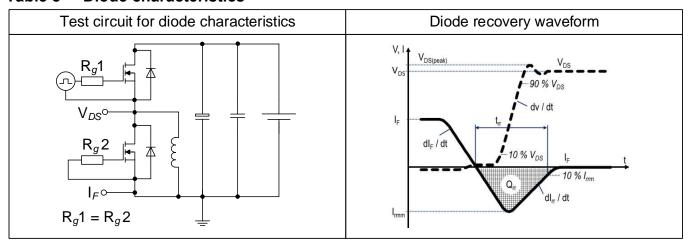
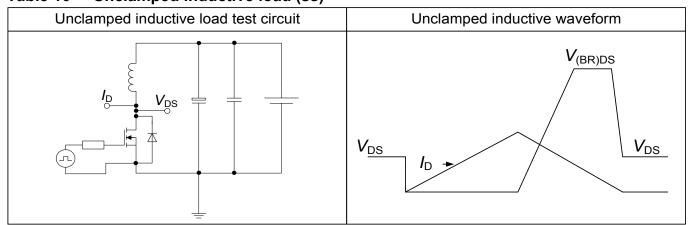


Table 9 Switching times (ss)



Table 10 Unclamped inductive load (ss)





# 6 Package Outlines

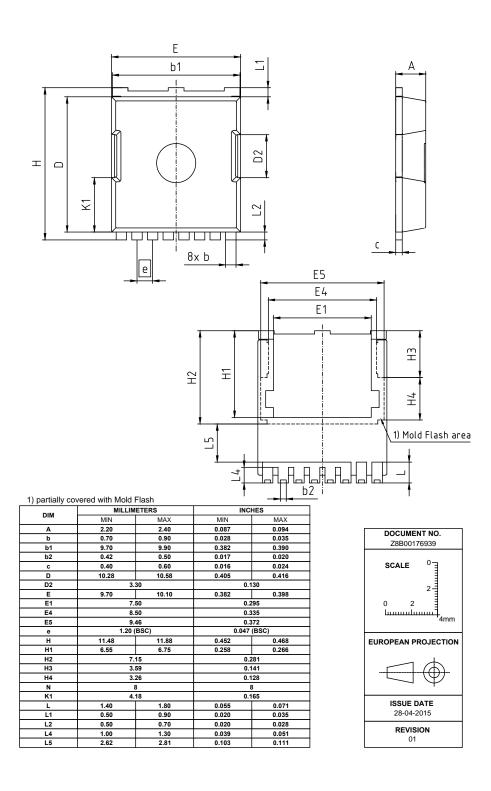


Figure 1 Outline PG-HSOF-8, dimensions in mm/inches

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# 7 Appendix A

## Table 11 Related Links

• IFX CoolMOS S7 Webpage: www.infineon.com

• IFX CoolMOS S7 application note: <a href="www.infineon.com">www.infineon.com</a>

• IFX CoolMOS S7 simulation model: www.infineon.com

• IFX Design tools: www.infineon.com

#### IPT60R022S7



#### **Revision History**

IPT60R022S7

Revision: 2021-10-25, Rev. 2.1

Previous	Revision

1 10110401	Troviduo Trovidion							
Revision	Date	Subjects (major changes since last revision)						
2.0	2019-05-07	Release of final version						
2.1	2021-10-25	Change of wording regarding breakdown voltage / cosmic ray						

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